

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
650V	$0.8\Omega@10V$	8A

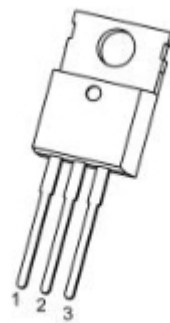
Feature

- Fast Switching
- Low Gate Charge and $R_{DS(on)}$
- 100% Single Pulse avalanche energy Test

Application

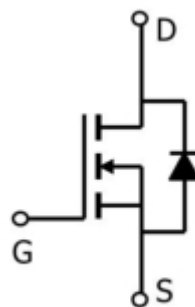
- DC-DC Converter
- Ideal for high-frequency switching and synchronous rectification

Package

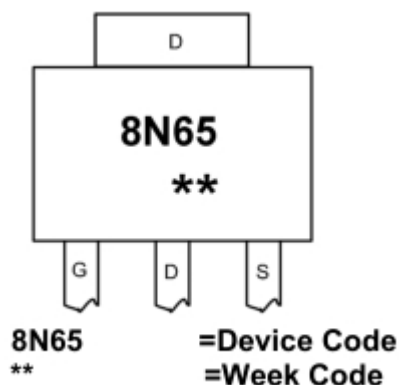


TO-220-3L-C(G:1 D:2 S:3)

Circuit diagram



Marking



Absolute maximum ratings

(T_a=25°C unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V _{DS}	650	V
Gate-Source Voltage	V _{GS}	±30	V
Continuous Drain Current ¹ (T _C =25°C)	I _D	8	A
Pulsed Drain Current ²	I _{DM}	32	A
Single Pulse Avalanche Energy ³	E _{AS}	408	mJ
Total Power Dissipation(T _C =25°C)	P _D	110	W
Thermal Resistance Junction-Case ¹	R _{θJC}	1.13	°C/ W
Storage Temperature Range	T _{STG}	-55~ +150	°C
Operating Junction Temperature Range	T _J	-55~ +150	°C

Electrical characteristics

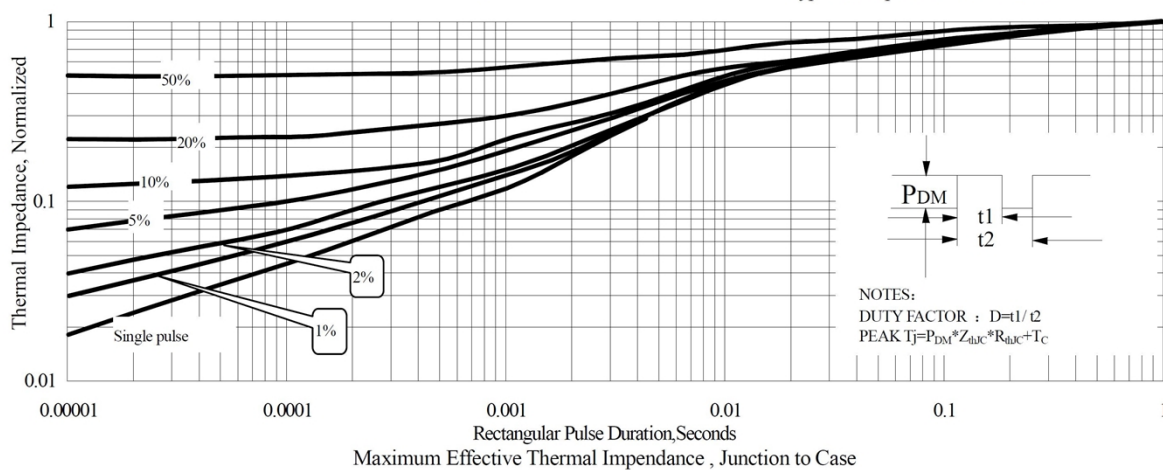
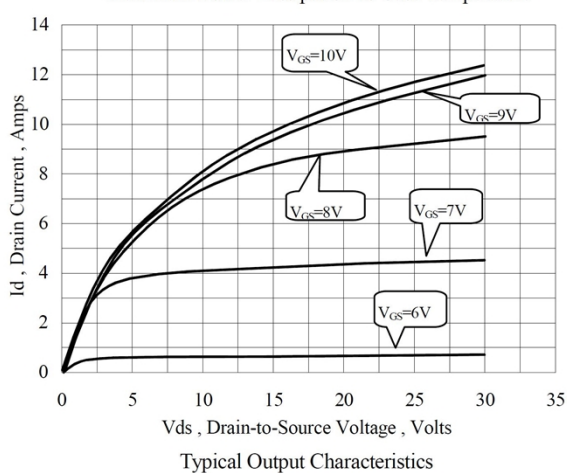
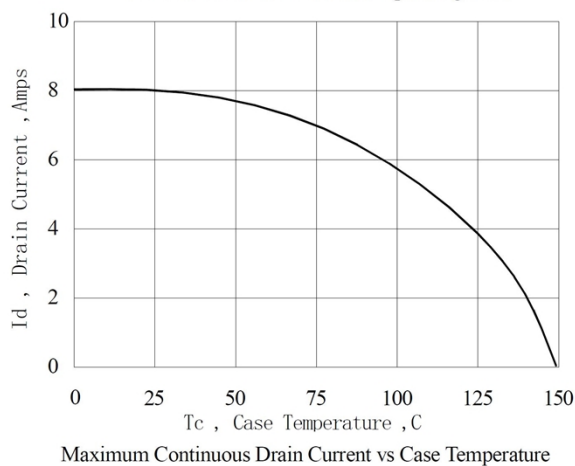
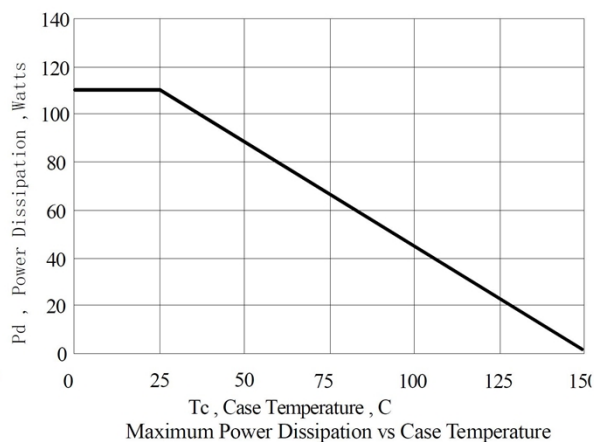
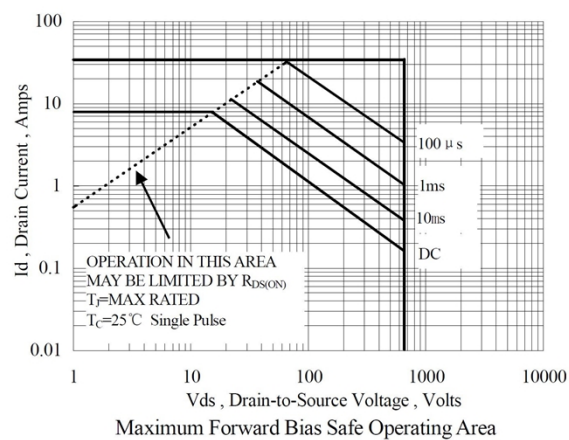
($T_A=25^{\circ}\text{C}$, unless otherwise noted)

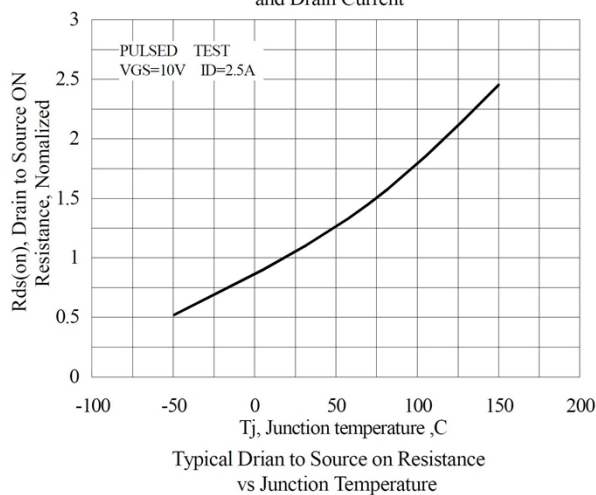
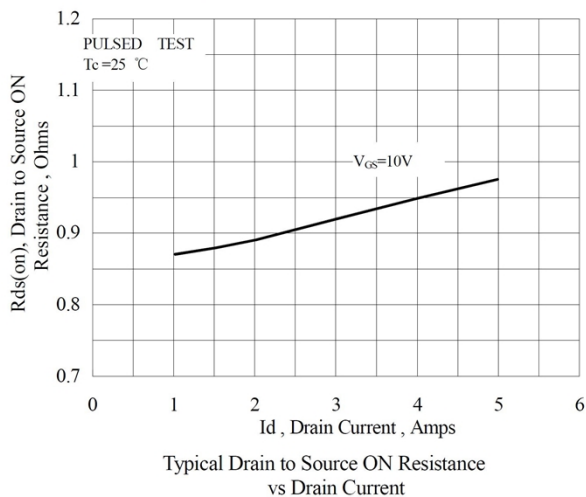
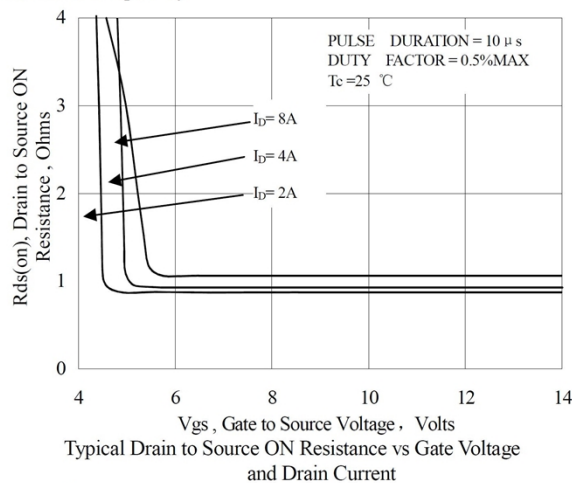
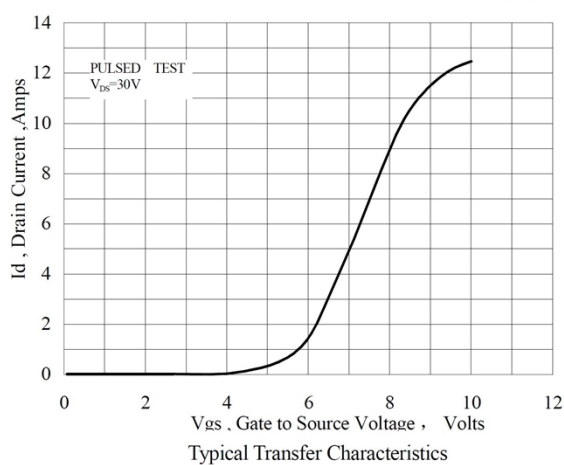
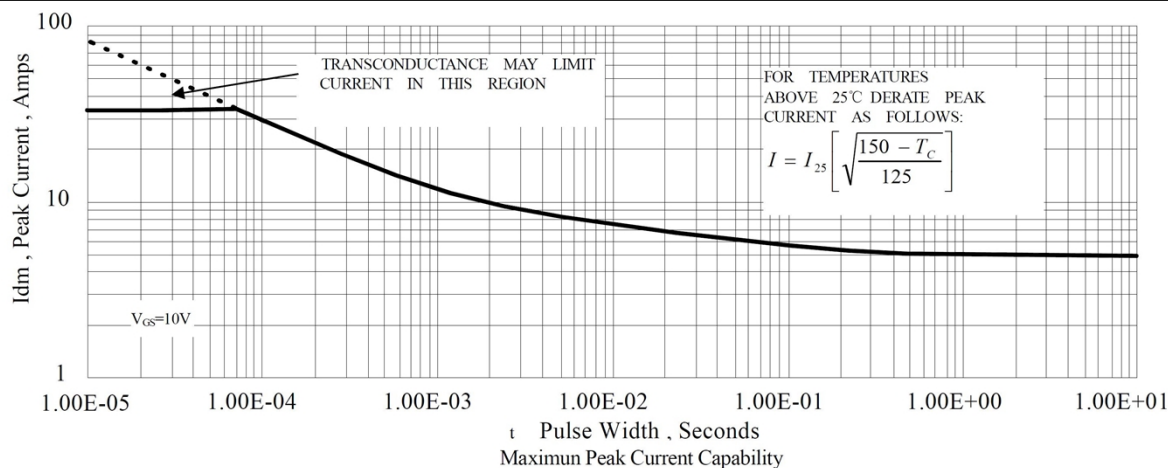
Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-source breakdown voltage	BV_{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	650			V
Drain-Source Leakage Current	I_{DSS}	$V_{DS} = 520V, V_{GS} = 0V$ $T_J = 25^{\circ}C$			1	μA
Gate-Source Leakage Current	I_{GSS}	$V_{GS} = \pm 30V, V_{DS} = 0V$			± 100	μA
Gate threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	2	3	4	V
Static Drain-Source on-Resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 4A$		0.8	1.1	Ω
Dynamic characteristics						
Input Capacitance	C_{iss}	$V_{DS} = 25V, V_{GS} = 0V,$ $f = 1MHz$		1233		pF
Output Capacitance	C_{oss}			117		
Reverse Transfer Capacitance	C_{rss}			15		
Switching Characteristics						
Total Gate Charge	Q_g	$V_{DS} = 325V, V_{GS} = 10V,$ $I_D = 8A$		28		nC
Gate-Source Charge	Q_{gs}			6		
Gate-Drain Charge	Q_{gd}			11		
Turn-On Delay Time	$T_{d(on)}$	$V_{DD} = 325V, V_{GS} = 6V,$ $R_G = 9\Omega, I_D = 8A$		13		nS
Rise Time	T_r			15		
Turn-Off Delay Time	$T_{d(off)}$			41		
Fall Time	T_f			21		

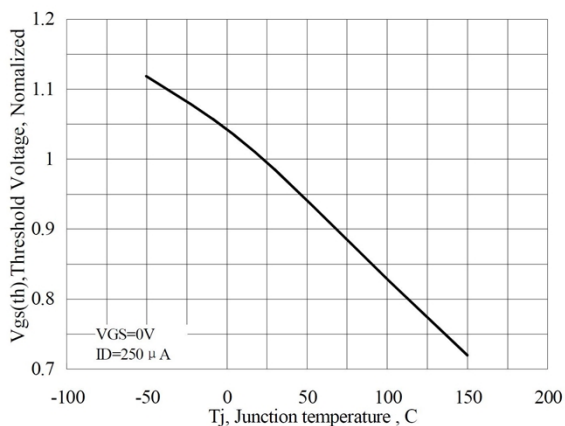
Notes:

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
2. The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
3. The EAS data shows Max. rating . The test condition is $R_G = 30\Omega, L = 10mH$

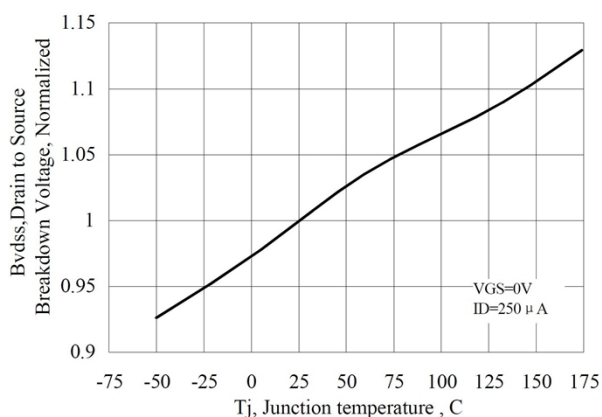
Typical Characteristics



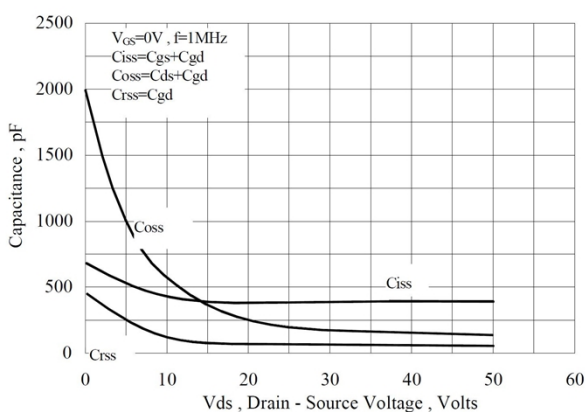




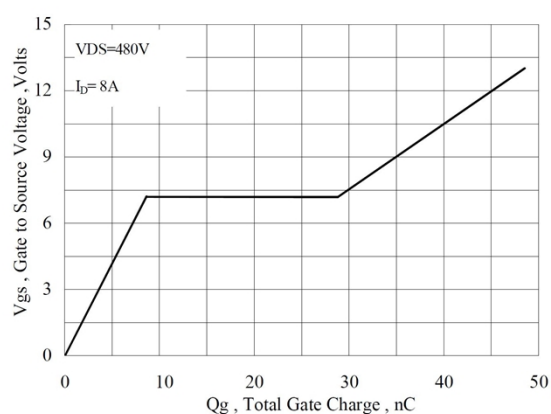
Typical Theshold Voltage vs Junction Temperature



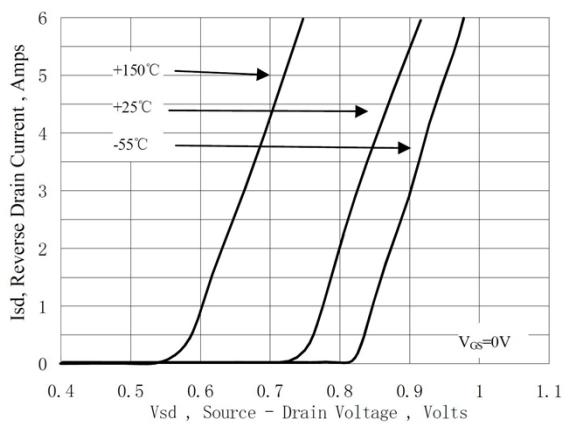
Typical Breakdown Voltage vs Junction Temperature



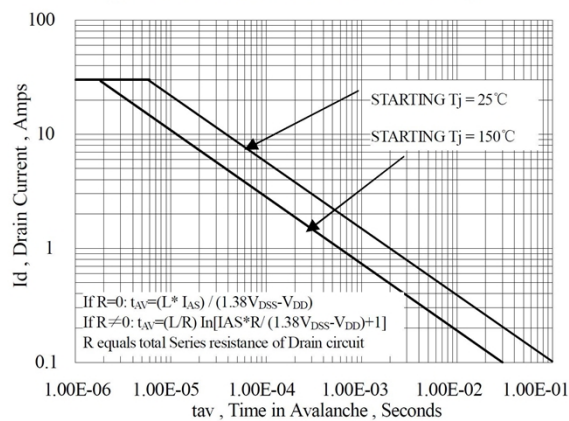
Typical Capacitance vs Drain to Source Voltage



Typical Gate Charge vs Gate to Source Voltage

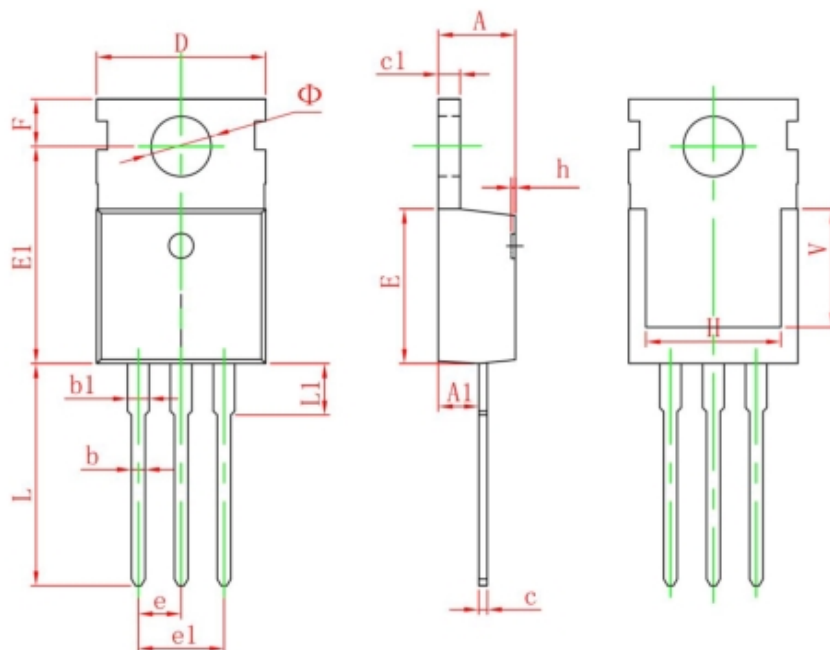


Typical Body Diode Transfer Characteristics



Unclamped Inductive Switching Capability

TO-220-3L-C Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.400	4.600	0.173	0.181
A1	2.250	2.550	0.089	0.100
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
c	0.330	0.650	0.013	0.026
c1	1.200	1.400	0.047	0.055
D	9.910	10.250	0.390	0.404
E	8.950	9.750	0.352	0.384
E1	12.650	13.050	0.498	0.514
e	2.540 TYP.		0.100 TYP.	
e1	4.980	5.180	0.196	0.204
F	2.650	2.950	0.104	0.116
H	7.900	8.100	0.311	0.319
h	0.000	0.300	0.000	0.012
L	12.900	13.400	0.508	0.528
L1	2.850	3.250	0.112	0.128
V	6.900 REF.		0.276 REF.	
Φ	3.400	3.800	0.134	0.150